Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/759,950	CHEN, CHYN HUEI	
Examiner	Art Unit	
Hadi Shakeri	3723	

SEARCHED					
Class	Subclass	Date	Examiner		
081	58.4, 59.1 60-63.2	8/15/2005	HS		
192	43.1, 43.2	8/15/2005	HS		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR		()
	DATE	EXMR
EAST	8/16/2005	нѕ
Inventor's Name Search	8/15/2005	нѕ
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